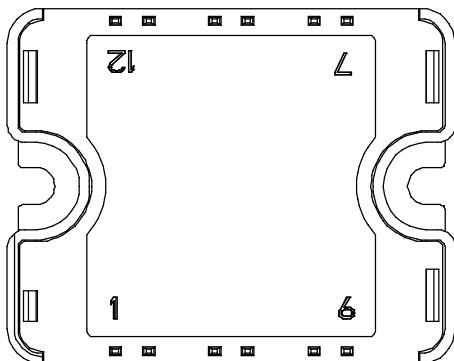
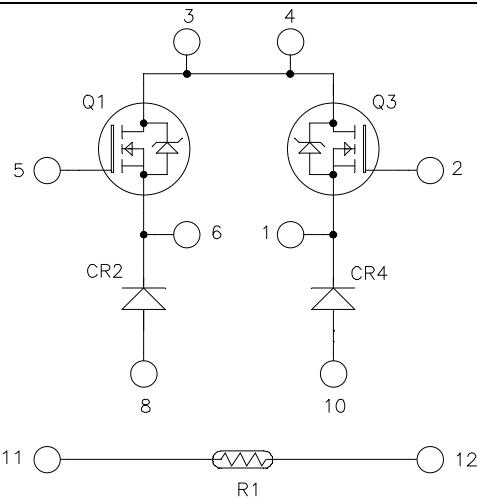


**Dual buck chopper
Super Junction MOSFET
SiC chopper diode**



Pins 3/4 must be shorted together

Absolute maximum ratings

Symbol	Parameter	Max ratings	Unit
V_{DSS}	Drain - Source Breakdown Voltage	900	V
I_D	Continuous Drain Current	$T_c = 25^\circ\text{C}$	A
		$T_c = 80^\circ\text{C}$	
I_{DM}	Pulsed Drain current	75	
V_{GS}	Gate - Source Voltage	± 20	V
R_{DSon}	Drain - Source ON Resistance	120	$\text{m}\Omega$
P_D	Maximum Power Dissipation	$T_c = 25^\circ\text{C}$	W
I_{AR}	Avalanche current (repetitive and non repetitive)	8.8	A
E_{AR}	Repetitive Avalanche Energy	2.9	
E_{AS}	Single Pulse Avalanche Energy	1940	mJ

 **CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

$V_{DSS} = 900\text{V}$

$R_{DSon} = 120\text{m}\Omega \text{ max @ } T_j = 25^\circ\text{C}$

$I_D = 30\text{A} @ T_c = 25^\circ\text{C}$

Application

- AC and DC motor control
- Switched Mode Power Supplies

Features

- **COOLMOS[®] Power Semiconductors**
 - Ultra low R_{DSon}
 - Low Miller capacitance
 - Ultra low gate charge
 - Avalanche energy rated
 - Very rugged
- **SiC Schottky Diode**
 - Zero reverse recovery
 - Zero forward recovery
 - Temperature Independent switching behavior
 - Positive temperature coefficient on VF
- Very low stray inductance
 - Symmetrical design
- Internal thermistor for temperature monitoring
- High level of integration

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

All ratings @ $T_j = 25^\circ\text{C}$ unless otherwise specified

Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0\text{V}, V_{DS} = 900\text{V}$	$T_j = 25^\circ\text{C}$			100
		$V_{GS} = 0\text{V}, V_{DS} = 900\text{V}$	$T_j = 125^\circ\text{C}$		500	
$R_{DS(on)}$	Drain – Source on Resistance	$V_{GS} = 10\text{V}, I_D = 26\text{A}$		100	120	$\text{m}\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 3\text{mA}$	2.5	3	3.5	V
I_{GSS}	Gate – Source Leakage Current	$V_{GS} = \pm 20\text{ V}, V_{DS} = 0\text{V}$			100	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
C_{iss}	Input Capacitance	$V_{GS} = 0\text{V} ; V_{DS} = 100\text{V}$ $f = 1\text{MHz}$		6800		pF
C_{oss}	Output Capacitance			330		
Q_g	Total gate Charge	$V_{GS} = 10\text{V}$ $V_{Bus} = 400\text{V}$ $I_D = 26\text{A}$		270		nC
Q_{gs}	Gate – Source Charge			32		
Q_{gd}	Gate – Drain Charge			115		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (125°C) $V_{GS} = 10\text{V}$ $V_{Bus} = 600\text{V}$ $I_D = 26\text{A}$ $R_G = 7.5\Omega$		70		ns
T_r	Rise Time			20		
$T_{d(off)}$	Turn-off Delay Time			400		
T_f	Fall Time			25		
E_{on}	Turn-on Switching Energy	Inductive switching @ 25°C $V_{GS} = 10\text{V} ; V_{Bus} = 600\text{V}$ $I_D = 26\text{A} ; R_G = 7.5\Omega$		900		μJ
E_{off}	Turn-off Switching Energy			750		
E_{on}	Turn-on Switching Energy	Inductive switching @ 125°C $V_{GS} = 10\text{V} ; V_{Bus} = 600\text{V}$ $I_D = 26\text{A} ; R_G = 7.5\Omega$		1278		μJ
E_{off}	Turn-off Switching Energy			867		

SiC chopper diode ratings and characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
V_{RRM}	Maximum Peak Repetitive Reverse Voltage		1200			V
I_{RM}	Maximum Reverse Leakage Current	$V_R = 1200\text{V}$	$T_j = 25^\circ\text{C}$	32	200	μA
			$T_j = 175^\circ\text{C}$	56	1000	
I_F	DC Forward Current		$T_c = 100^\circ\text{C}$	10		A
V_F	Diode Forward Voltage	$I_F = 10\text{A}$	$T_j = 25^\circ\text{C}$	1.6	1.8	V
			$T_j = 175^\circ\text{C}$	2.3	3	
Q_C	Total Capacitive Charge	$I_F = 10\text{A}, V_R = 600\text{V}$ $di/dt = 500\text{A}/\mu\text{s}$		40		nC
C	Total Capacitance	$f = 1\text{MHz}, V_R = 200\text{V}$		96		pF
		$f = 1\text{MHz}, V_R = 400\text{V}$		69		

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic		Min	Typ	Max	Unit
R ₂₅	Resistance @ 25°C			50		kΩ
ΔR _{25/R25}				5		%
B _{25/85}	T ₂₅ = 298.15 K			3952		K
ΔB/B		T _C =100°C		4		%

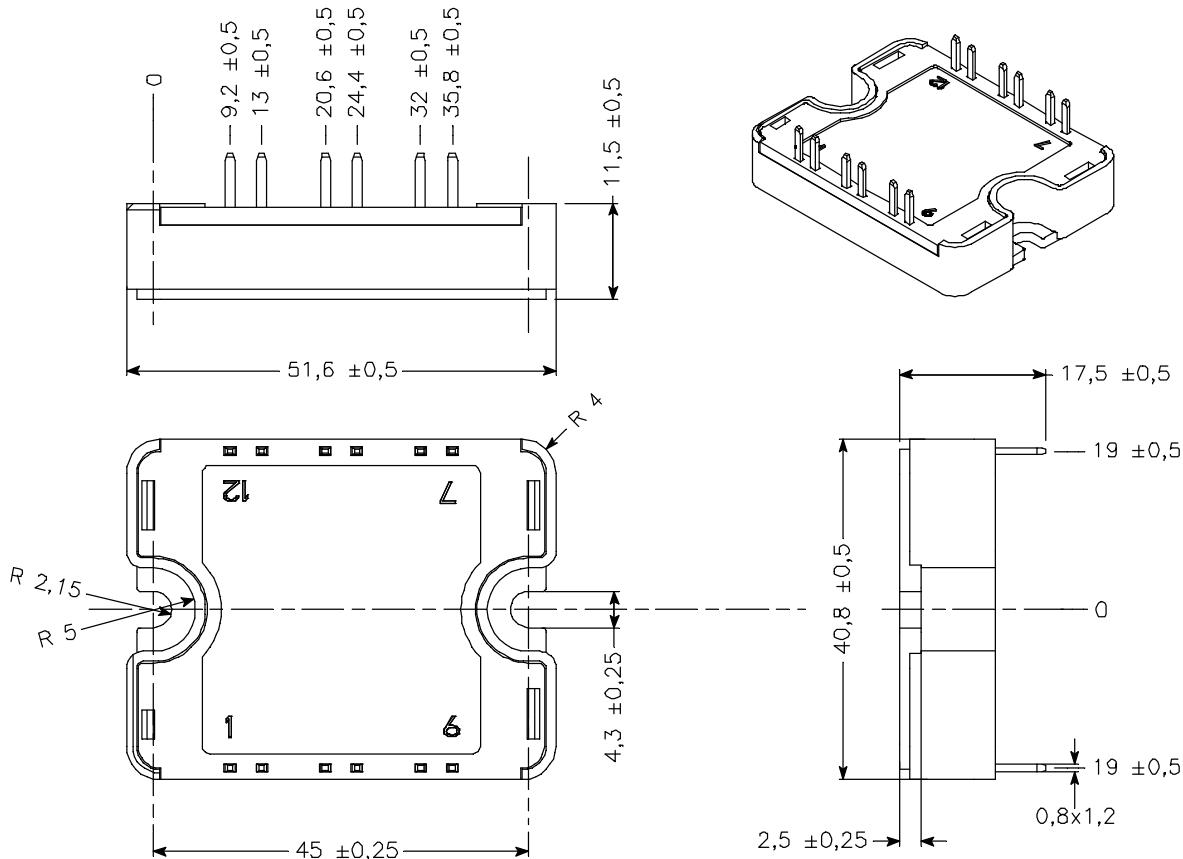
$$R_T = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$

T: Thermistor temperature
R_T: Thermistor value at T

Thermal and package characteristics

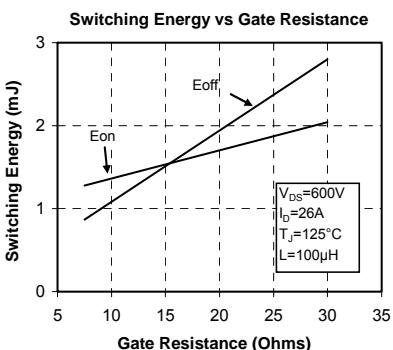
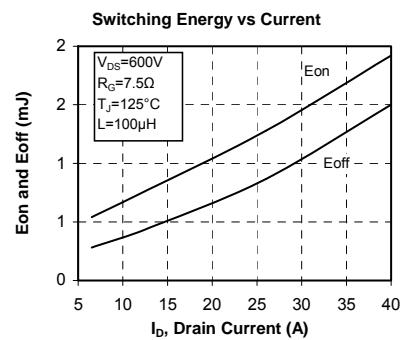
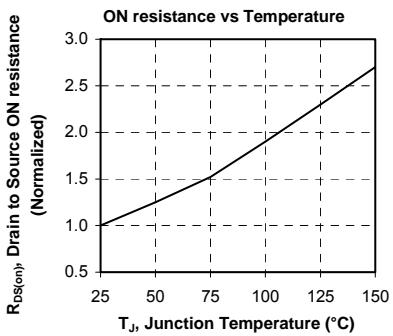
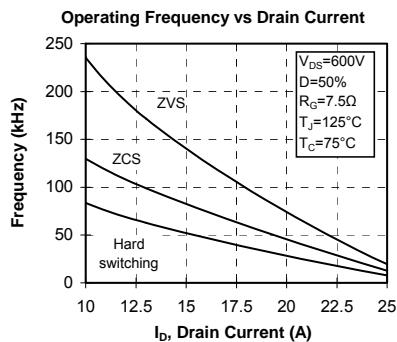
Symbol	Characteristic		Min	Typ	Max	Unit
R _{thJC}	Junction to Case Thermal Resistance	CoolMOS			0.5	°C/W
		SiC Diode			1.8	
V _{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, I isol<1mA, 50/60Hz		4000			V
T _J	Operating junction temperature range		-40		150	
T _{STG}	Storage Temperature Range		-40		125	°C
T _C	Operating Case Temperature		-40		100	
Torque	Mounting torque	To heatsink	M4	2.5	4.7	N.m
Wt	Package Weight				80	g

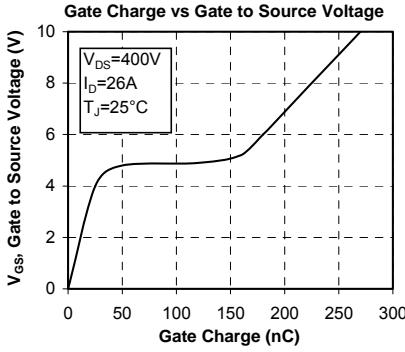
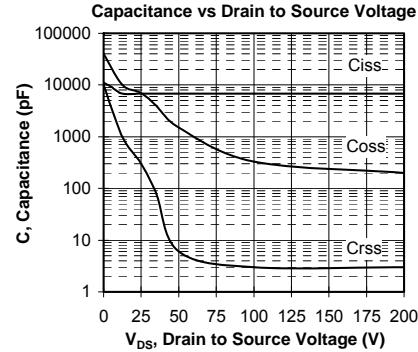
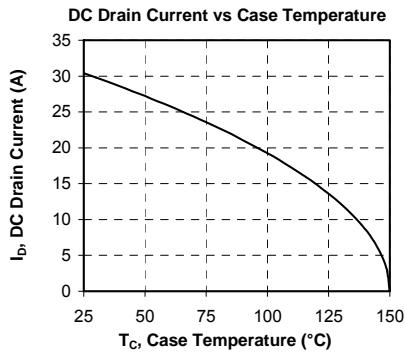
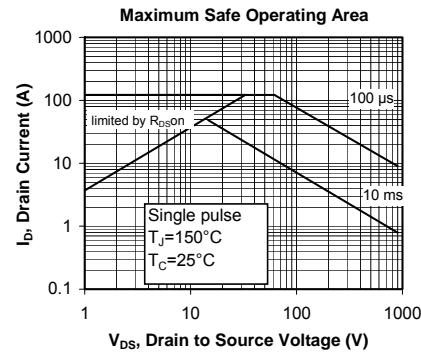
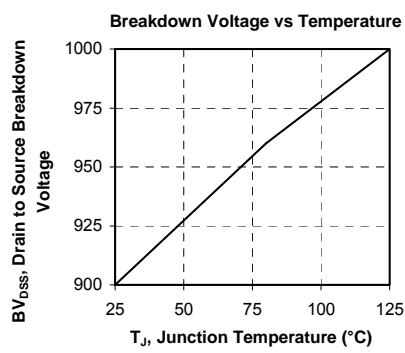
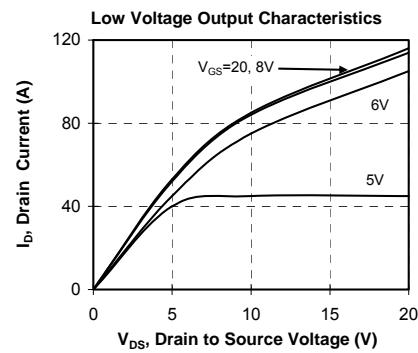
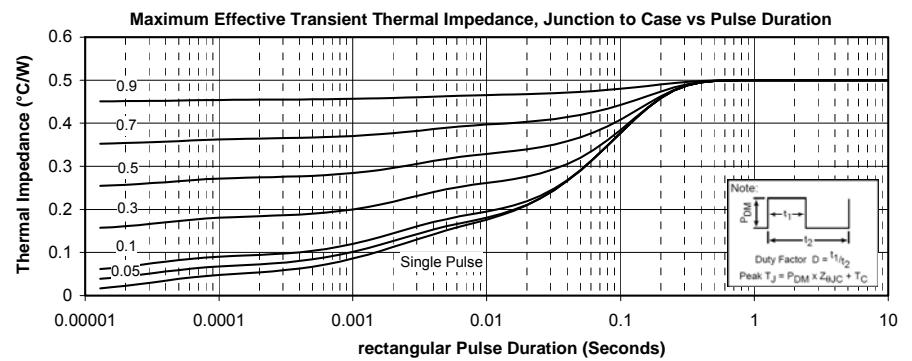
SP1 Package outline (dimensions in mm)



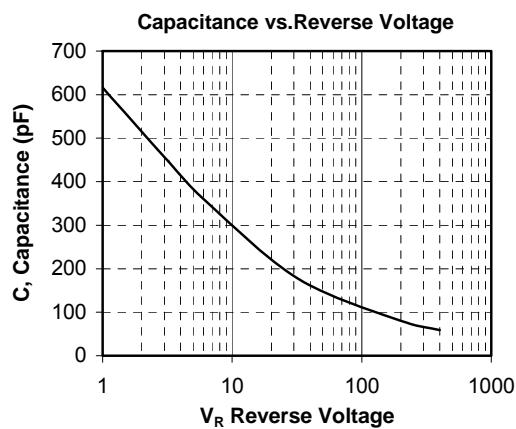
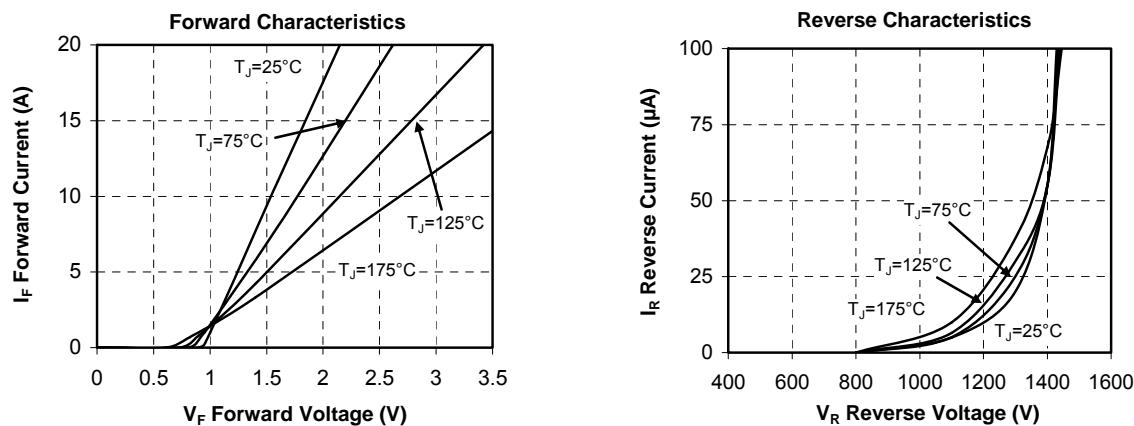
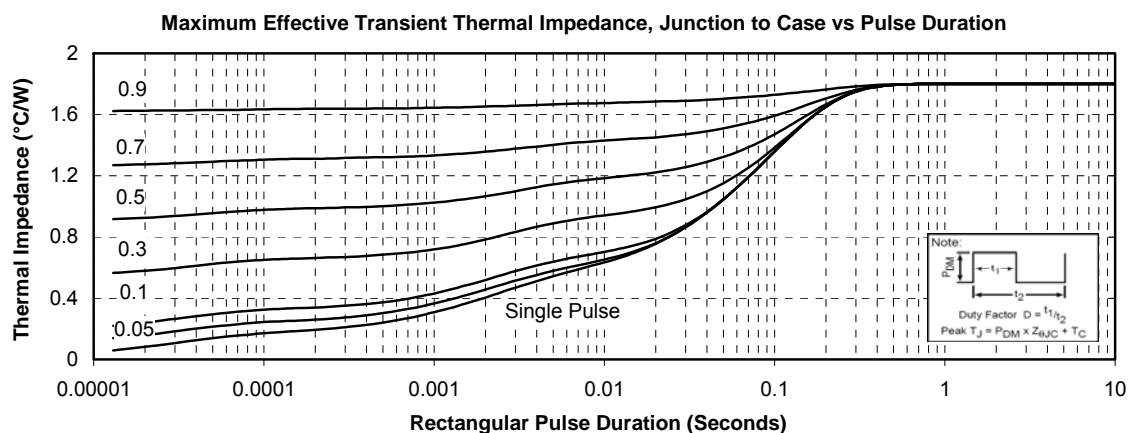
See application note 1904 - Mounting Instructions for SP1 Power Modules on www.microsemi.com

Typical CoolMOS Performance Curve





Typical SiC Diode Performance Curve



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